

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/629,894	YONEZAWA, MINORU	
Examiner		Art Unit		Page 1 of 1
TAN X. DINH		2627		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,121,370 a	06-1992	Yanagi, Shigenori	369/30.15
*	B	US-5,696,743	12-1997	Kawasaki, Satoshi	369/30.13
*	C	US-6,370,091 b1	04-2002	Kuroda, Kazuo	369/30.08
*	D	US-5,471,441 a	11-1995	Nonaka et al.	369/30.11
*	E	US-6,834,028 b2	12-2004	Itoh et al.	369/30.17
*	F	US-5,920,527 a	07-1999	Aoki, Nobuyuki	369/30.15
*	G	US-6,330,212 b1	12-2001	Iida, Michihiko	369/30.16
*	H	US-6,801,494 b2	10-2004	Ross, Kevin	369/275.3
*	I	US-6,606,283 b2	08-2003	Chan, Yi-Chung	369/30.15
*	J	US-5,808,982 a	09-1998	Yun, Ki-bong	369/30.13
*	K	US-6,704,252 b2	03-2004	Aso et al.	369/30.11
*	L	US-2004/0001410 a1	01-2004	Yonezawa, Minoru	369/53.24
*	M	US-2004/0076091 a1	04-2004	Yonezawa, Minoru	369/30.11

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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